

Member State of OIML
Japan



OIML Certificate No
R76/1992-JP1-05.02

OIML CERTIFICATE OF CONFORMITY

Issuing authority

Name: National Institute of Advanced Industrial Science and Technology
Address: 1-3-1, Kasumigaseki, Chiyoda-ku, TOKYO, 100-8921, Japan
Person responsible: Hiroyuki Yoshikawa

Applicant

Name: A&D Company, Limited
Address: 3-23-14 Higashi-ikebukuro, Toshima-ku, Tokyo 170-0013, JAPAN

Manufacturer of the certified pattern

Name: A&D SCALES CO.,LTD.
Address: 162-4 INSAN-NI, DEOGSAN-MYEON, JINCHEON-GUN,
CHUNGCHONGBUG-DO, KOREA

Identification of the certified pattern:

Type EK-i(K)
Further characteristics see page 2

This certificate attests the conformity of the above-mentioned pattern (represented by the samples identified in the associated test report) with the requirements of the following Recommendation(s) of the International Organization of Legal Metrology (OIML):

R76-1, edition 1992, including amendment 1 (1994),
for accuracy class **II** and **III**

This certificate relates only to the metrological and technical characteristics of the pattern of the instrument concerned, as covered by the relevant OIML International Recommendation(s).

This certificate does not bestow any form of legal international approval.

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The conformity was established by tests described in the associated test report
N° 05-02-A/R76 (53 pages) and N° 05-02-B/R76 (25 pages).

The Issuing Authority

The OIML member



Dr. H. Yoshikawa

President

Dec 26 2005

Dr. Y. Miki

Dec 26 2005

Characteristics:

| Type | EK-i (K) | |
|----------------------|-----------------|----------------|
| Accuracy class | II | III |
| Max | 600 g~6000 g | 400 g~6000 g |
| $e \geq$ | 0.1 g or 1 g | 0.1 g or 1 g |
| $d \geq$ | 0.01 g or 0.1 g | 0.01g or 0.1 g |
| n | ≤ 6000 | ≤ 6000 |
| Min | 0.5 g or 5 g | 0.2 g or 2 g |
| Tare-balancing range | 100% of Max | |
| Temperature range | 5 °C / 35 °C | |

Important note: Apart from the mention of certificate's reference number and the name of the OIML Member State in which the certificate was issued, partial quotation of the certificate or of the associated test report is not permitted, though they may be reproduced in full.